Sub	Substitute for form 1449A/PTO			Complete if Known		
				Application Number		
IN	FORMATIO	N DI	SCLOSURE	Filing Date	February 3, 2004	
ST	CATEMENT	BY A	PPLICANT	First Named Inventor	David R. BROWN et al.	
				Group Art Unit		
	(use as many sheets as necessary)			Examiner Name		
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OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS					
Examiner	Cite	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book,	T*		
Initials*	No.	magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country			
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number.

² See attached Kinds of U.S. Patent Documents.

For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible.

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